

Search Notes

Application/Control No.

10/057,756

Examiner

Michael W. Bowen

Applicant(s)/Patent under
Reexamination

IMAGAWA ET AL.

Art Unit

2625

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Subclass/text search: 382/181,190,191,195,199,209,232,23 5,276,280 and template and (orthogonal or Fourier)	10/7/2005	MWB
Talked to Senior Examiner Wenpeng Chen	10/17/2005	MWB